



Form 1449 (Modified) Information Disclosur Stat ment By Applicant (Use Several Sheets if Necessary)	Attorney Docket No: SUNMP008 Applicant: Sharma et al. Filing Date: April 30, 2001	U.S. 09/846,492 ✓ Group: 2152
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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
ES	A	6,182,086	01/2001	Lomet et al.			
	B						
	C						
	D						
	E						

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Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	F							
	G							
	H							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
ES	I	Sailil Deshpande, "Clustering: Transparent Replication, Load Balancing, and Failover," January 2000, Retrieved from the Internet: < http://bdn.borland.com/article/images/26438/11501_r1.pdf >
	J	Silva et al., "Fault-Tolerant Execution of Mobile Agents," Dependable Systems and Networks, 2000. DSN 2000. Proceedings International Conference on New York, NY, USA 25-28 June 2000, IEEE Comput. Soc., US, 25 June 2000 pages 135-143
	K	Little et al., "Maintaining Information about Persistent Replicated Objects in a Distributed System," Proceedings of the International Conference on Distributed Computing Systems. Pittsburgh, PA, May 25-28, 1993 and IEEE Comp. Soc. Press, U.S., Vol. CONF. 13, 25 May 1993, pages 491-498.
	L	Sonntag et al., "Adaptability Using Reflection," System Sciences, 1994, Vol. II: Software Technology, Proceedings of the Twenty-Seventh Hawaii International Conference on Wailea, HI, USA, 4-7 January 1994 pages 383-392
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Examiner EL HADJI SALI		Date Considered 06/25/04

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.